

**WPM1485**
**Single P-Channel, -12V, -7.4A, Power MOSFET**
[Http://www.willsemi.com](http://www.willsemi.com)

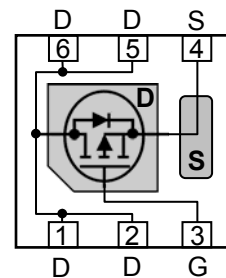
V <sub>DS</sub> (V)	R <sub>ds(on)</sub> (Ω)
-12	0.015@ V <sub>GS</sub> = - 4.5V
	0.020@ V <sub>GS</sub> = - 2.5V
	0.030@ V <sub>GS</sub> = - 1.8V



DFN2×2-6L

**Descriptions**

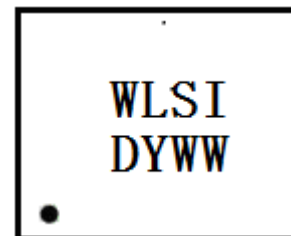
The WPM1485 is P-Channel enhancement MOS Field Effect Transistor. Uses advanced trench technology and design to provide excellent R<sub>DS(ON)</sub> with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit. Standard Product WPM1485 is Pb-free and Halogen-free.


**Pin configuration (Top view)**
**Features**

- Trench Technology
- Supper high density cell design
- Excellent ON resistance for higher DC current
- Extremely Low Threshold Voltage
- Small package DFN2×2-6L

**Applications**

- Driver for Relay, Solenoid, Motor, LED etc.
- DC-DC converter circuit
- Power Switch
- Load Switch
- Charging



WLSI = Willsemi  
 D = Device Code  
 YY = Year  
 WW = Week  
**Marking**

**Order information**

Device	Package	Shipping
WPM1485-6/TR	DFN2×2-6L	3000/Reel&Tape

**Absolute Maximum ratings**

Parameter		Symbol	10 S	Steady State	Unit
Drain-Source Voltage		$V_{DS}$	-12		V
Gate-Source Voltage		$V_{GS}$	±8		
Continuous Drain Current <sup>a</sup>	$T_A=25^{\circ}\text{C}$	$I_D$	-7.4	-6.4	A
	$T_A=70^{\circ}\text{C}$		-5.9	-5.1	
Maximum Power Dissipation <sup>a</sup>	$T_A=25^{\circ}\text{C}$	$P_D$	1.8	1.3	W
	$T_A=70^{\circ}\text{C}$		1.1	0.8	
Continuous Drain Current <sup>b</sup>	$T_A=25^{\circ}\text{C}$	$I_D$	-5.7	-4.6	A
	$T_A=70^{\circ}\text{C}$		-4.5	-3.6	
Maximum Power Dissipation <sup>b</sup>	$T_A=25^{\circ}\text{C}$	$P_D$	1.0	0.6	W
	$T_A=70^{\circ}\text{C}$		0.6	0.4	
Pulsed Drain Current <sup>c</sup>		$I_{DM}$	-30		A
Operating Junction Temperature		$T_J$	-55~+150		°C
Lead Temperature		$T_L$	260		°C
Storage Temperature Range		$T_{stg}$	-55 to 150		°C

**Thermal resistance ratings**

Parameter		Symbol	Typical	Maximum	Unit
Junction-to-Ambient Thermal Resistance <sup>a</sup>	$t \leq 10 \text{ s}$	$R_{\theta JA}$	55	69	°C/W
	Steady State		70	91	
Junction-to-Ambient Thermal Resistance <sup>b</sup>	$t \leq 10 \text{ s}$	$R_{\theta JA}$	88	115	
	Steady State		125	179	
Junction-to-Case Thermal Resistance		$R_{\theta JC}$	34	44	

a Surface mounted on FR-4 Board using 1 square inch pad size, 1oz copper

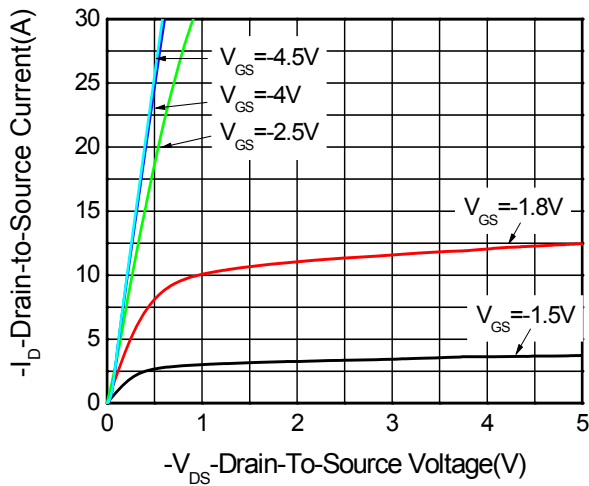
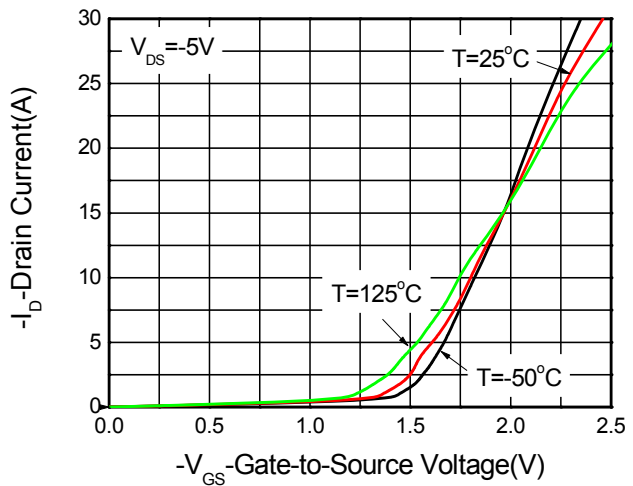
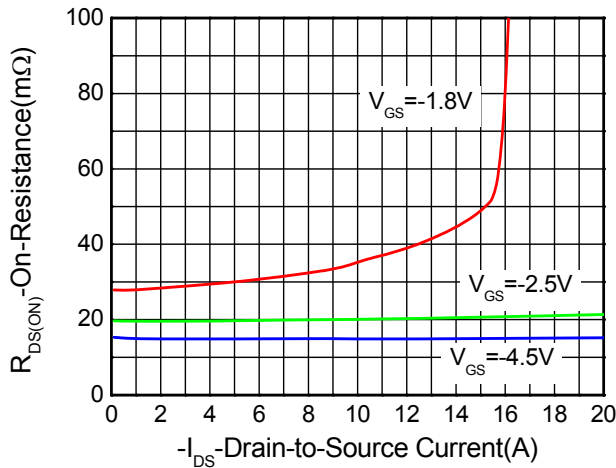
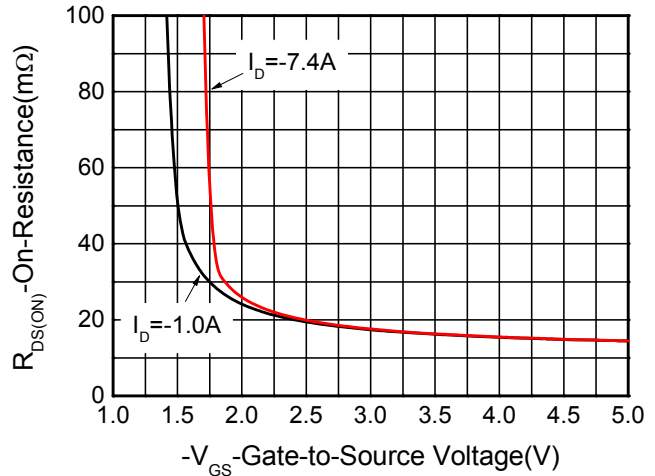
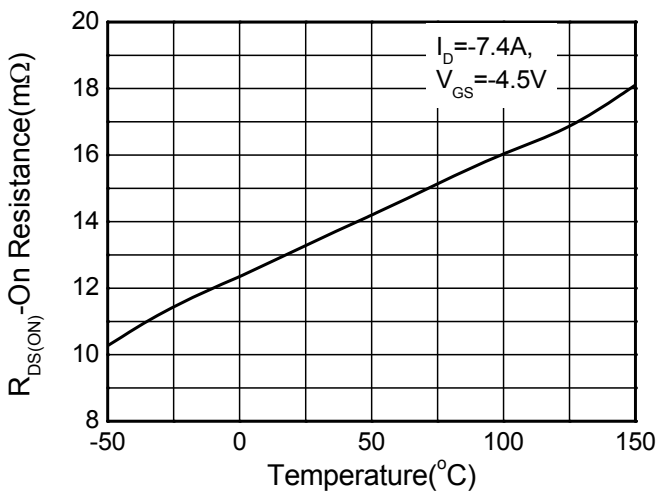
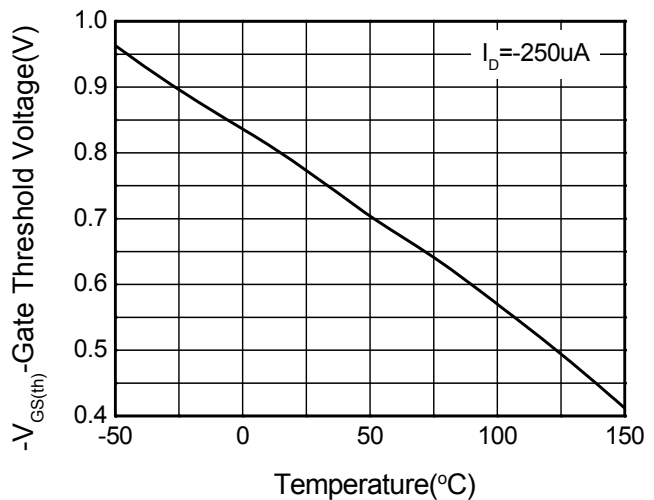
b Surface mounted on FR-4 board using minimum pad size, 1oz copper

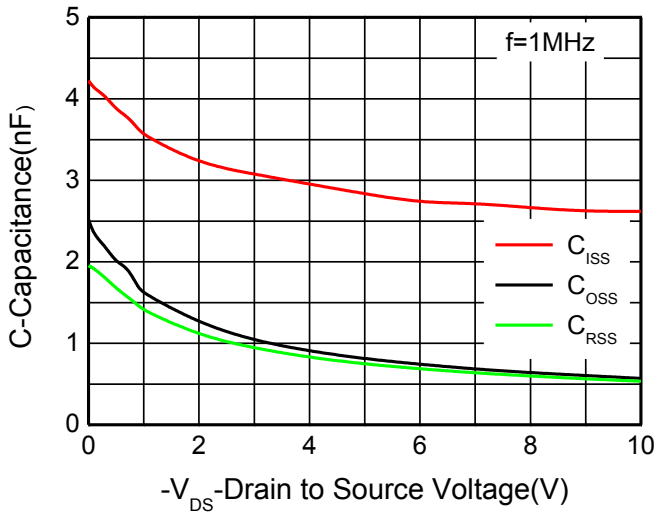
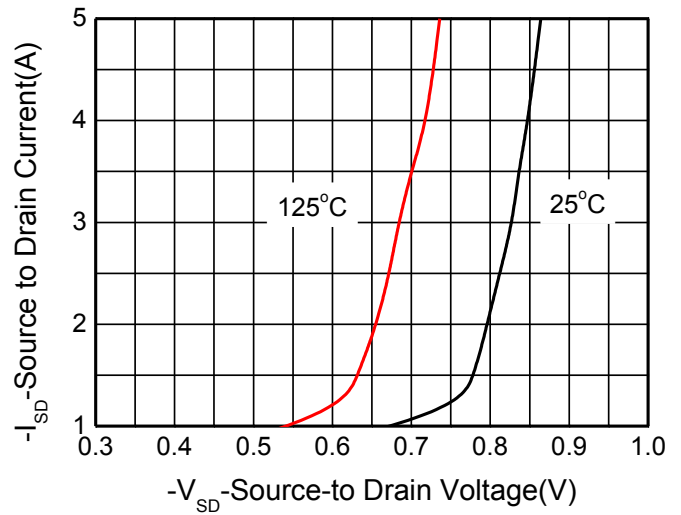
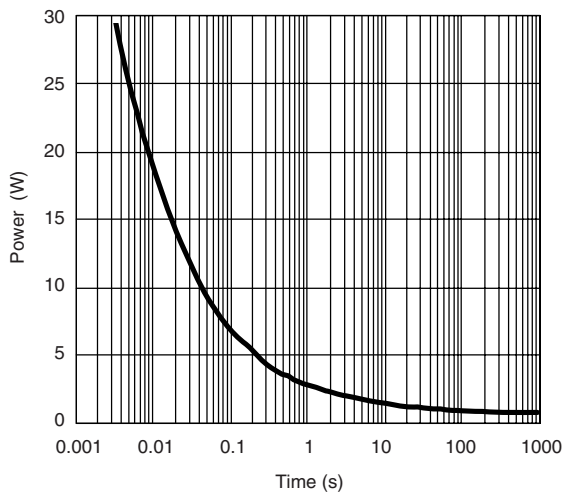
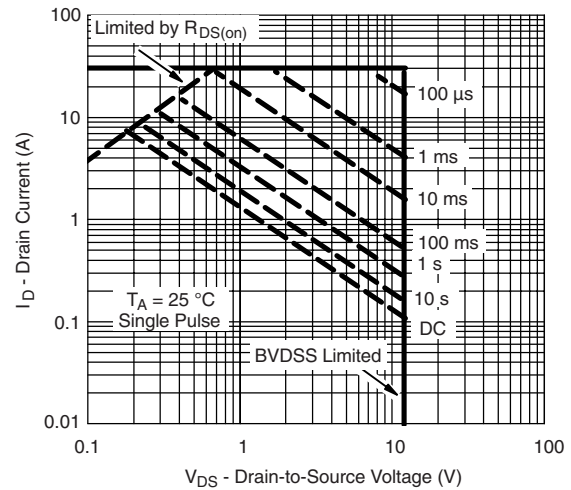
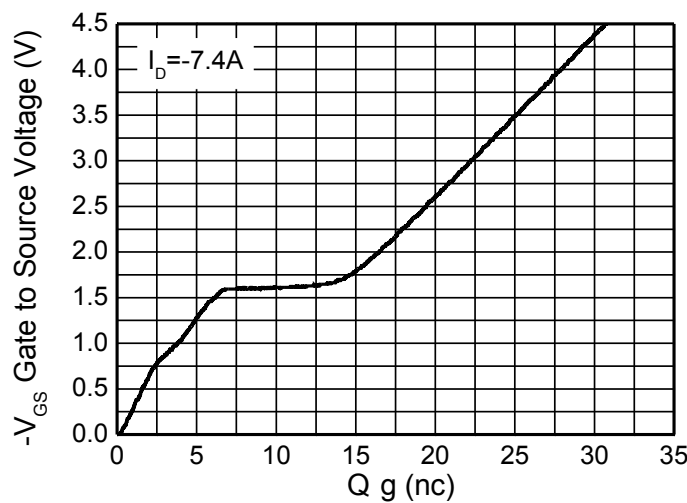
c Pulse width<380μs, Duty Cycle<2%

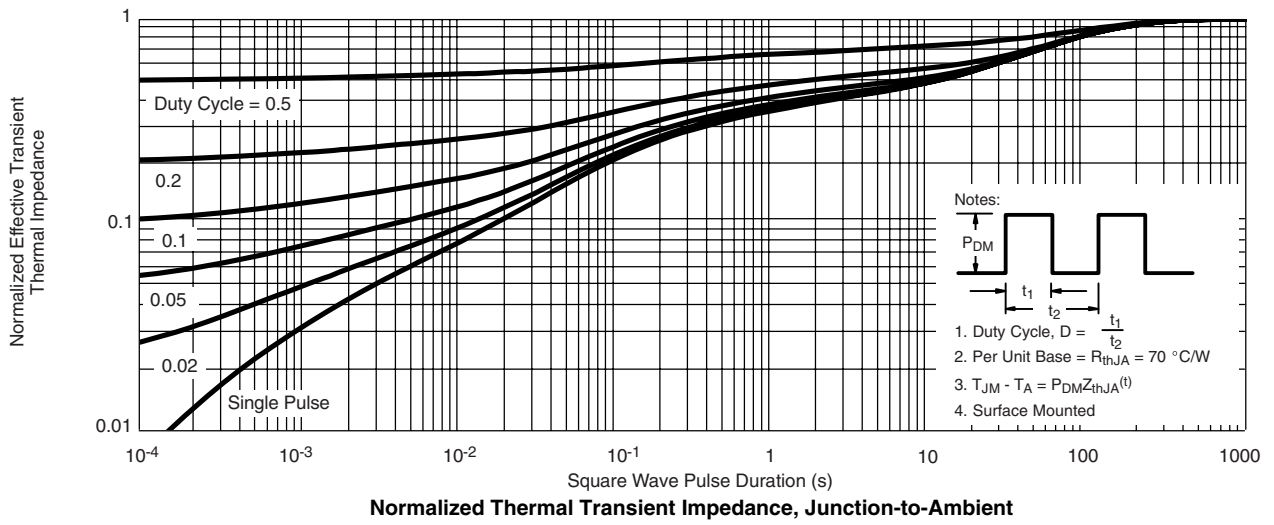
d Maximum junction temperature  $T_J=150^{\circ}\text{C}$ .

**Electronics Characteristics (Ta=25°C, unless otherwise noted)**

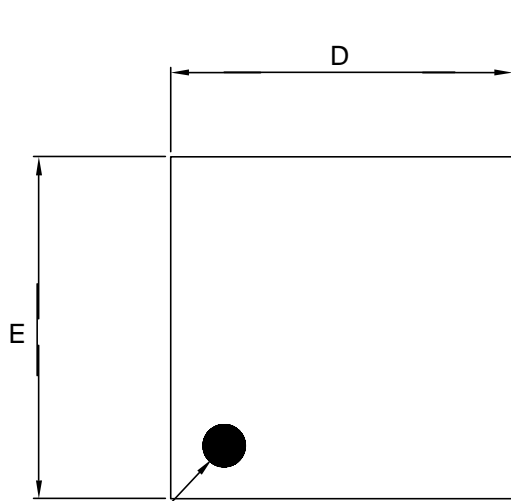
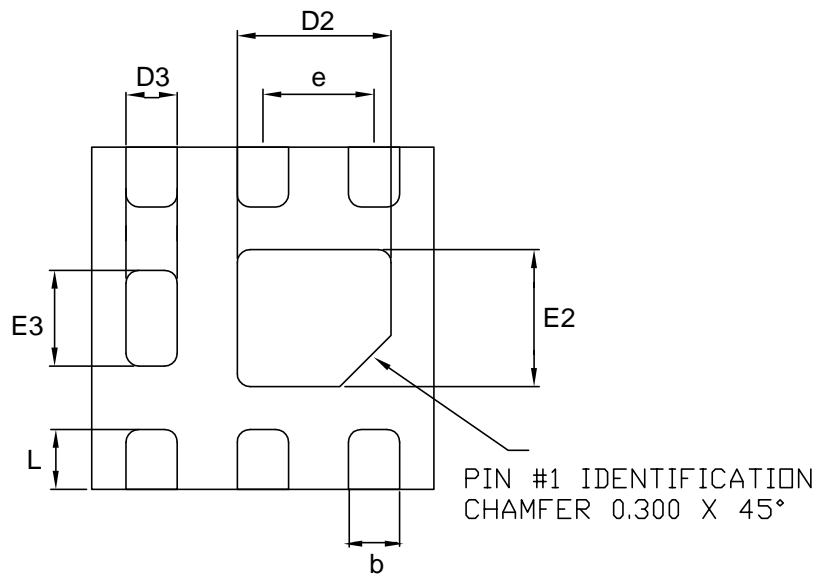
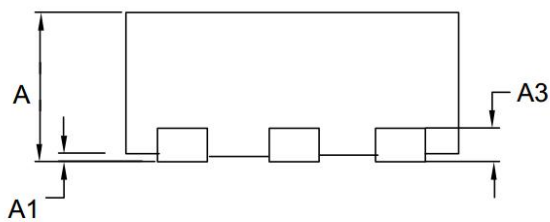
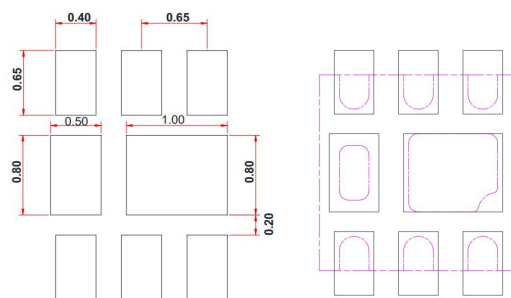
Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>OFF CHARACTERISTICS</b>						
Drain-to-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS} = 0\text{ V}, I_D = -250\mu\text{A}$	-12			V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = -10\text{ V}, V_{GS} = 0\text{ V}$			-1	$\mu\text{A}$
Gate-to-source Leakage Current	$I_{GSS}$	$V_{DS} = 0\text{ V}, V_{GS} = \pm 8\text{ V}$			$\pm 100$	nA
<b>ON CHARACTERISTICS</b>						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = -250\mu\text{A}$	-0.45	-0.60	-0.95	V
Drain-to-source On-resistance <sup>b, c</sup>	$R_{DS(on)}$	$V_{GS} = -4.5\text{ V}, I_D = -7.4\text{ A}$		15	19	m $\Omega$
		$V_{GS} = -2.5\text{ V}, I_D = -6.5\text{ A}$		20	23	
		$V_{GS} = -1.8\text{ V}, I_D = -2.3\text{ A}$		30	45	
Forward Transconductance	$g_{FS}$	$V_{DS} = -5.0\text{ V}, I_D = -7.4\text{ A}$		21		S
<b>CAPACITANCES, CHARGES</b>						
Input Capacitance	$C_{ISS}$	$V_{GS} = 0\text{ V},$		2620		pF
Output Capacitance	$C_{OSS}$	$f = 1.0\text{ MHz},$		570		
Reverse Transfer Capacitance	$C_{RSS}$	$V_{DS} = -10\text{ V}$		530		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = -4.5\text{ V},$ $V_{DS} = -6.0\text{ V},$ $I_D = -7.4\text{ A}$		30.75		nC
Threshold Gate Charge	$Q_{G(TH)}$			1.90		
Gate-to-Source Charge	$Q_{GS}$			6.10		
Gate-to-Drain Charge	$Q_{GD}$			7.60		
<b>SWITCHING CHARACTERISTICS</b>						
Turn-On Delay Time	$t_d(ON)$	$V_{GS} = -4.5\text{ V},$ $V_{DD} = -6.0\text{ V},$ $I_D = -7.4\text{ A},$ $R_G = 6\ \Omega$		22		ns
Rise Time	$t_r$			40		
Turn-Off Delay Time	$t_d(OFF)$			90		
Fall Time	$t_f$			65		
<b>BODY DIODE CHARACTERISTICS</b>						
Forward Voltage	$V_{SD}$	$V_{GS} = 0\text{ V}, I_S = -8.0\text{ A}$		-0.88	-1.5	V

**Typical Characteristics (Ta=25°C, unless otherwise noted)**

**Output characteristics**

**Transfer characteristics**

**On-Resistance vs. Drain current**

**On-Resistance vs. Gate-to-Source voltage**

**On-Resistance vs. Junction temperature**

**Threshold voltage vs. Temperature**


**Capacitance**

**Body diode forward voltage**

**Single Pulse Power, Junction-to-Ambient**

**Safe Operating Area, Junction-to-Ambient**

**Gate Charge Characteristics**



### Transient thermal response (Junction-to-Ambient)

**Package outline dimensions**
**DFN2\*2-6L**

**Top view**

**Bottom view**

**Side View**

**Recommend land pattern (Unit: mm)**

*Note: This land pattern is for your reference only. Actual pad layouts may vary depending on application.*

Symbol	Dimensions in millimeter		
	Min.	Typ.	Max.
A	0.70	0.75	0.80
A1	0.00	-	0.05
A3	0.203 Ref.		
D	1.95	2.00	2.05
E	1.95	2.00	2.05
D2	0.85	0.90	0.95
E2	0.75	0.80	0.85
D3	0.25	0.30	0.35
E3	0.51	0.56	0.61
b	0.25	0.30	0.35
L	0.30	0.35	0.40
e	0.65 BSC.		